











CSD19538Q3A

SLPS583A -MAY 2016-REVISED MARCH 2017

CSD19538Q3A 100-V N-Channel NexFET™ Power MOSFET

Features

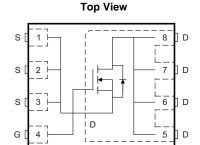
- Ultra-Low Qa and Qad
- Low-Thermal Resistance
- Avalanche Rated
- Lead Free
- **RoHS Compliant**
- Halogen Free
- SON 3.3-mm × 3.3-mm Plastic Package

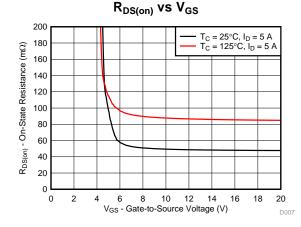
Applications

- Power Over Ethernet (PoE)
- Power Sourcing Equipment (PSE)
- Motor Control

Description 3

This 100-V, 49-m Ω , SON 3.3-mm × 3.3-mm NexFET™ power MOSFET is designed to minimize conduction losses and reduce board footprint in PoE applications.





Product Summary

$T_A = 25^\circ$	С	TYPICAL VA	UNIT	
V_{DS}	Drain-to-Source Voltage	100		V
Q_g	Gate Charge Total (10 V)	4.3	nC	
Q_{gd}	Gate Charge Gate to Drain	0.8	nC	
D	Drain-to-Source On Resistance	V _{GS} = 6 V 58		mΩ
R _{DS(on)}	Diam-to-Source Off Resistance	V _{GS} = 10 V 49		11122
$V_{GS(th)}$	Threshold Voltage	3.2	٧	

Device Information⁽¹⁾

DEVICE	MEDIA	QTY	PACKAGE	SHIP
CSD19538Q3A	13-Inch Reel	3000	SON	Tape
CSD19538Q3AT	7-Inch Reel	250	3.30-mm x 3.30-mm Plastic Package	and Reel

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Absolute Maximum Ratings

T _A = 2	5°C	VALUE	UNIT	
V_{DS}	Drain-to-Source Voltage	100	V	
V_{GS}	Gate-to-Source Voltage	±20	V	
	Continuous Drain Current (Package Limited)	15		
I _D	Continuous Drain Current (Silicon Limited), $T_C = 25^{\circ}C$	14	Α	
	Continuous Drain Current ⁽¹⁾	4.9		
I_{DM}	Pulsed Drain Current ⁽²⁾	37	Α	
D	Power Dissipation ⁽¹⁾	2.8	W	
P_D	Power Dissipation, T _C = 25°C	23	VV	
T _J , T _{stg}	Operating Junction Temperature, Storage Temperature	-55 to 150	°C	
E _{AS}	Avalanche Energy, Single Pulse I_D = 12.7 A, L = 0.1 mH, R_G = 25 Ω	8.1	mJ	

- (1) Typical $R_{\theta JA} = 45^{\circ}\text{C/W}$ on a 1-in², 2-oz Cu pad on a 0.06 in thick FR4 PCB.
- (2) Max $R_{\theta,IC} = 5.5$ °C/W, pulse duration $\leq 100 \mu s$, duty cycle \leq

Gate Charge

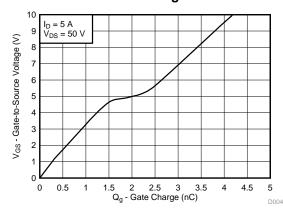




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4 Revision History

Cł	nanges from Original (May 2016) to Revision A	Page
•	Changed the test voltage V _{DS} in Gate Charge curve from 100 V : to 50 V	1
•	Changed the test voltage V _{DS} in Figure 4 from 100 V : to 50 V	5
•	Added Receiving Notification of Documentation Updates section to Device and Documentation Support section	<mark>7</mark>

Product Folder Links: CSD19538Q3A

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5 Specifications

5.1 Electrical Characteristics

 $T_{\Delta} = 25^{\circ}C$

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
STATIC	CHARACTERISTICS		·		
BV _{DSS}	Drain-to-source voltage	V _{GS} = 0 V, I _D = 250 μA	100		V
I _{DSS}	Drain-to-source leakage current	$V_{GS} = 0 \text{ V}, V_{DS} = 80 \text{ V}$		1	μΑ
I _{GSS}	Gate-to-source leakage current	V _{DS} = 0 V, V _{GS} = 20 V		100	nA
V _{GS(th)}	Gate-to-source threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.8 3.2	3.8	V
	Designate and an analystance	V _{GS} = 6 V, I _D = 5 A	58	72	0
R _{DS(on)}	Drain-to-source on resistance	V _{GS} = 10 V, I _D = 5 A	49	59	mΩ
9 _{fs}	Transconductance	V _{DS} = 10 V, I _D = 5 A	6.1		S
DYNAMI	C CHARACTERISTICS		ı		
C _{iss}	Input capacitance		349	454	pF
C _{oss}	Output capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 50 \text{ V}, f = 1 \text{ MHz}$	69	90	pF
C _{rss}	Reverse transfer capacitance		12.6	16.4	pF
R _G	Series gate resistance		4.6	9.2	Ω
Qg	Gate charge total (10 V)		4.3		nC
Q _{gd}	Gate charge gate-to-drain		0.8		nC
Q _{gs}	Gate charge gate-to-source	$V_{DS} = 50 \text{ V}, I_{D} = 5 \text{ A}$	1.6		nC
Q _{g(th)}	Gate charge at V _{th}		1		nC
Q _{oss}	Output charge	V _{DS} = 50 V, V _{GS} = 0 V	12.3		nC
t _{d(on)}	Turnon delay time		5		ns
t _r	Rise time	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V},$	3		ns
t _{d(off)}	Turnoff delay time	$I_{DS} = 5 \text{ A}, R_G = 0 \Omega$	7		ns
t _f	Fall time		2		ns
DIODE C	CHARACTERISTICS			'	
V _{SD}	Diode forward voltage	I _{SD} = 5 A, V _{GS} = 0 V	0.85	1	V
Q _{rr}	Reverse recovery charge	V _{DS} = 50 V, I _F = 5 A,	94		nC
t _{rr}	Reverse recovery time	di/dt = 300 A/μs	32		ns

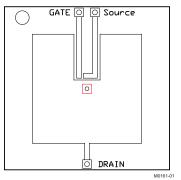
5.2 Thermal Information

 $T_A = 25$ °C (unless otherwise stated)

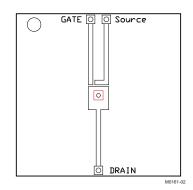
	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-case thermal resistance ⁽¹⁾			5.5	°C/W
$R_{\theta JA}$	Junction-to-ambient thermal resistance ⁽¹⁾⁽²⁾			55	°C/W

 ⁽¹⁾ R_{θ,JC} is determined with the device mounted on a 1-in² (6.45-cm²), 2-oz (0.071-mm) thick Cu pad on a 1.5-in x 1.5-in (3.81-cm x 3.81-cm), 0.06-in (1.52-mm) thick FR4 PCB. R_{θ,JC} is specified by design, whereas R_{θ,JA} is determined by the user's board design.
 (2) Device mounted on FR4 material with 1-in² (6.45-cm²), 2-oz (0.071-mm) thick Cu.





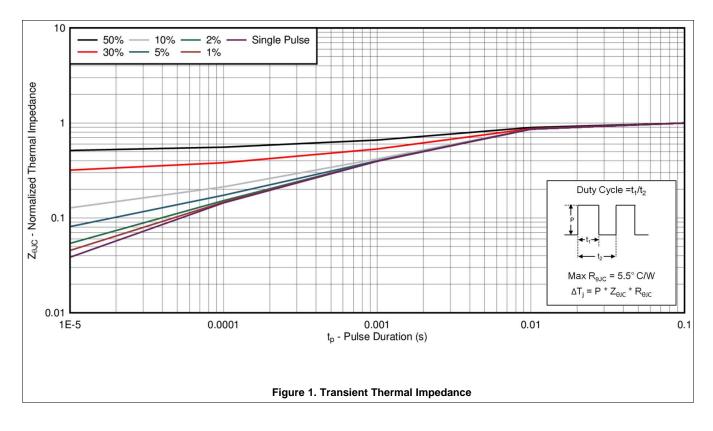
Max $R_{\theta JA} = 55^{\circ}\text{C/W}$ when mounted on 1-in² (6.45-cm²) of 2-oz (0.071-mm) thick Cu.



Max $R_{\theta JA} = 195^{\circ} C/W$ when mounted on a minimum pad area of 2-oz (0.071-mm) thick Cu.

5.3 Typical MOSFET Characteristics

 $T_A = 25$ °C (unless otherwise stated)



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Typical MOSFET Characteristics (continued)

 $T_A = 25^{\circ}C$ (unless otherwise stated)

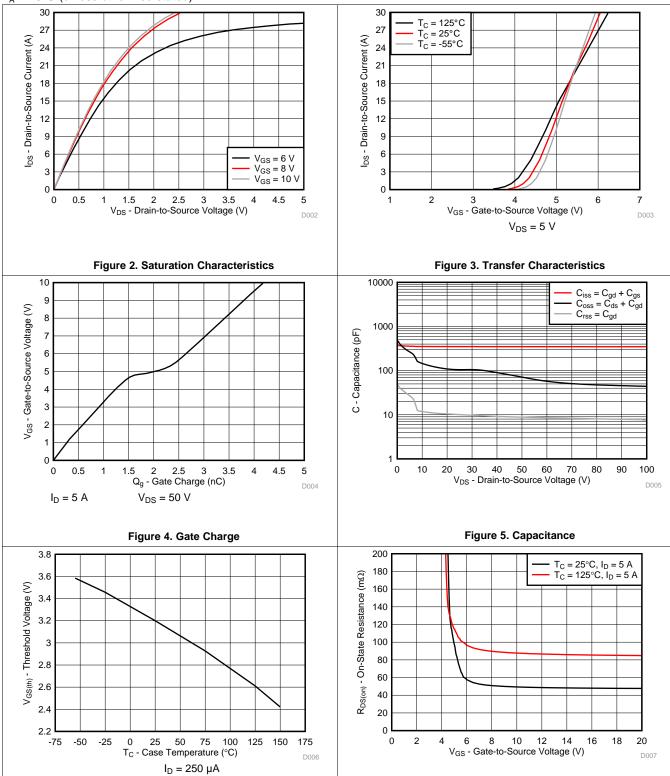


Figure 6. Threshold Voltage vs Temperature

Figure 7. On-State Resistance vs Gate-to-Source Voltage

1000

0.01

0.1

DC

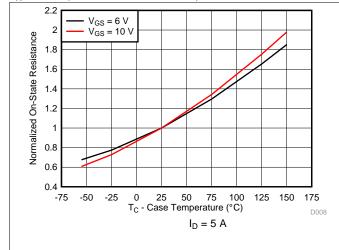
1 ms

10 ms



Typical MOSFET Characteristics (continued)

 $T_A = 25$ °C (unless otherwise stated)



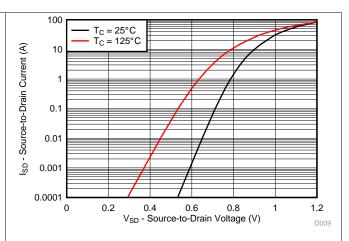
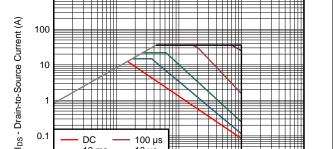


Figure 8. Normalized On-State Resistance vs Temperature



· 10 µs

Figure 9. Typical Diode Forward Voltage

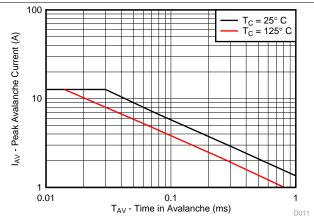


Figure 10. Maximum Safe Operating Area

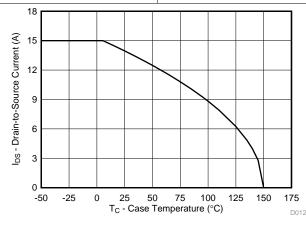
10

V_{DS} - Drain-to-Source Voltage (V)

Single pulse, max $R_{\theta JC} = 5.5$ °C/W

100





1000

D010

Figure 12. Maximum Drain Current vs Temperature

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6 Device and Documentation Support

6.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

6.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

6.3 Trademarks

NexFET, E2E are trademarks of Texas Instruments.

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6.4 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

6.5 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

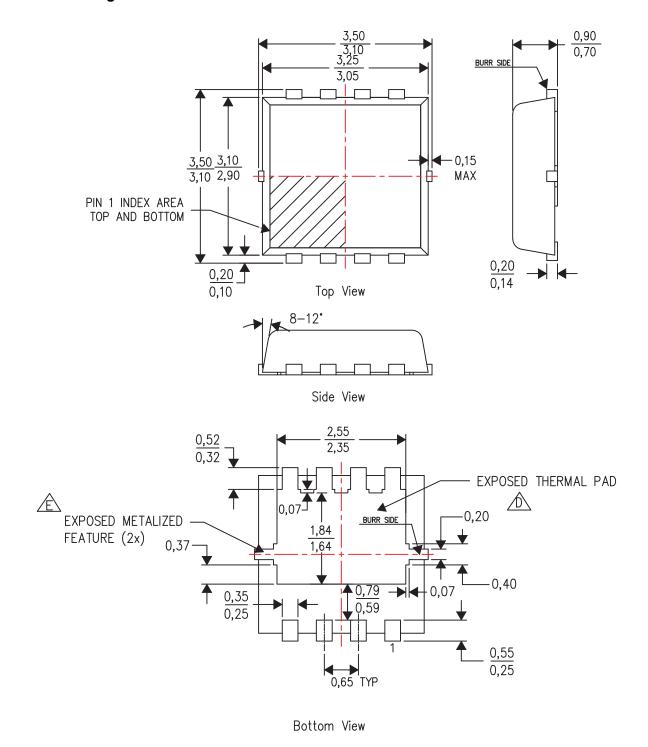
Product Folder Links: CSD19538Q3A



7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

7.1 Q3A Package Dimensions

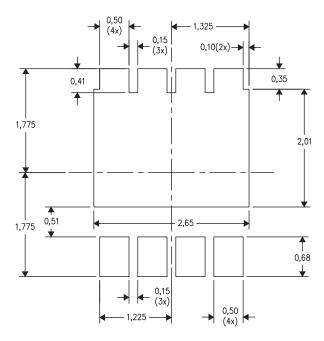


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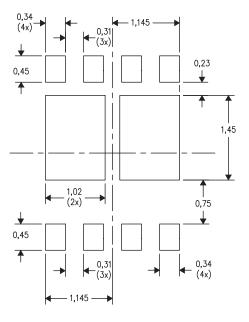


7.2 Q3A Recommended PCB Pattern



For recommended circuit layout for PCB designs, see *Reducing Ringing Through PCB Layout Techniques* (SLPA005).

7.3 Q3A Recommended Stencil Pattern

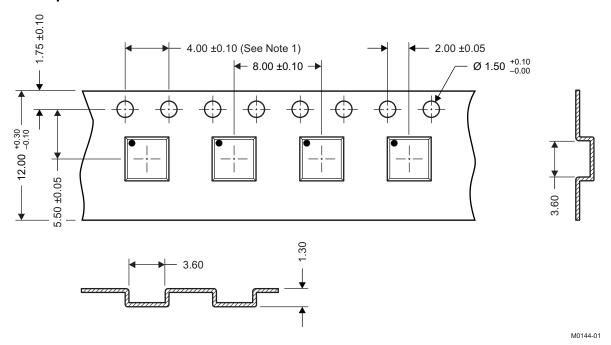


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7.4 Q3A Tape and Reel Information



Notes: 1. 10-sprocket hole-pitch cumulative tolerance ±0.2.

- 2. Camber not to exceed 1 mm in 100 mm, noncumulative over 250 mm.
- 3. Material: black static-dissipative polystyrene.
- 4. All dimensions are in mm, unless otherwise specified.
- 5. Thickness: 0.3 ±0.05 mm.
- 6. MSL1 260°C (IR and convection) PbF-reflow compatible.

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www.ti.com 23-May-2025

PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
	(1)	(2)			(5)	(4)	(5)		(0)
CSD19538Q3A	Active	Production	VSONP (DNH) 8	2500 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-55 to 150	19538
CSD19538Q3A.B	Active	Production	VSONP (DNH) 8	2500 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-55 to 150	19538
CSD19538Q3AT	Active	Production	VSONP (DNH) 8	250 SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-55 to 150	19538
CSD19538Q3AT.B	Active	Production	VSONP (DNH) 8	250 SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-55 to 150	19538

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

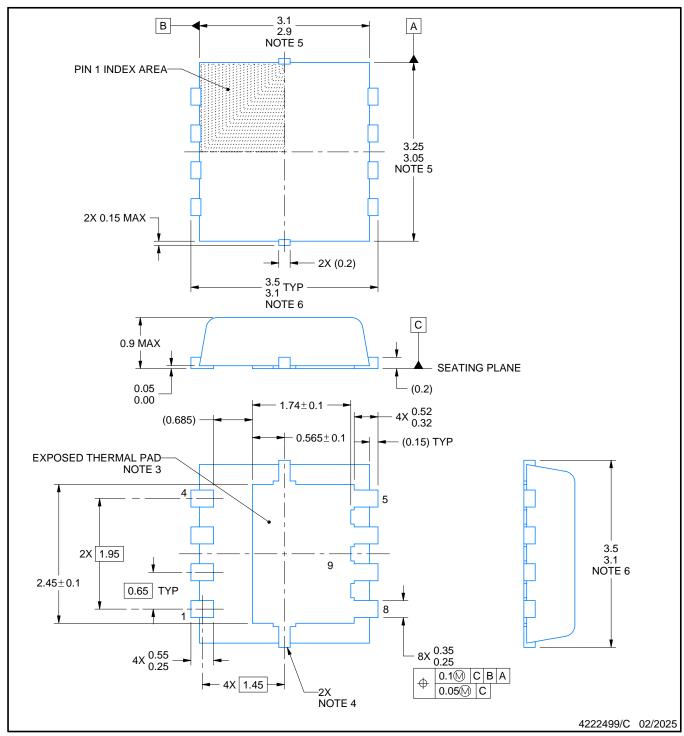
⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



PLASTIC SMALL OUTLINE - NO LEAD

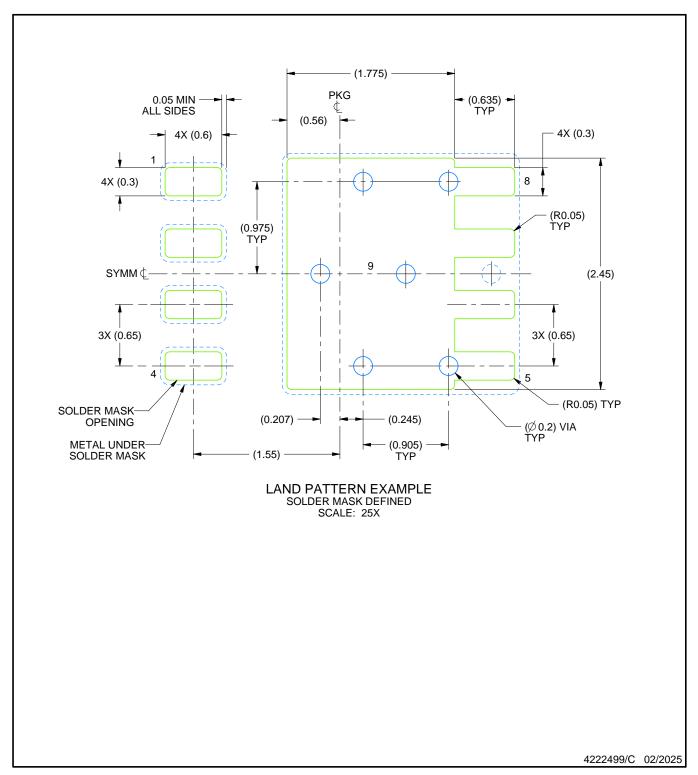


NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- This drawing is subject to change without notice.
 The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.
- 4. Metalized features are supplier options and may not be on the package.
- 5. These dimensions do not include mold flash protrusions or gate burrs.
- 6. These dimensions include interterminal flash or protrusion. Interterminal flash or protrusion shall not exceed 0.25 mm per side.



PLASTIC SMALL OUTLINE - NO LEAD

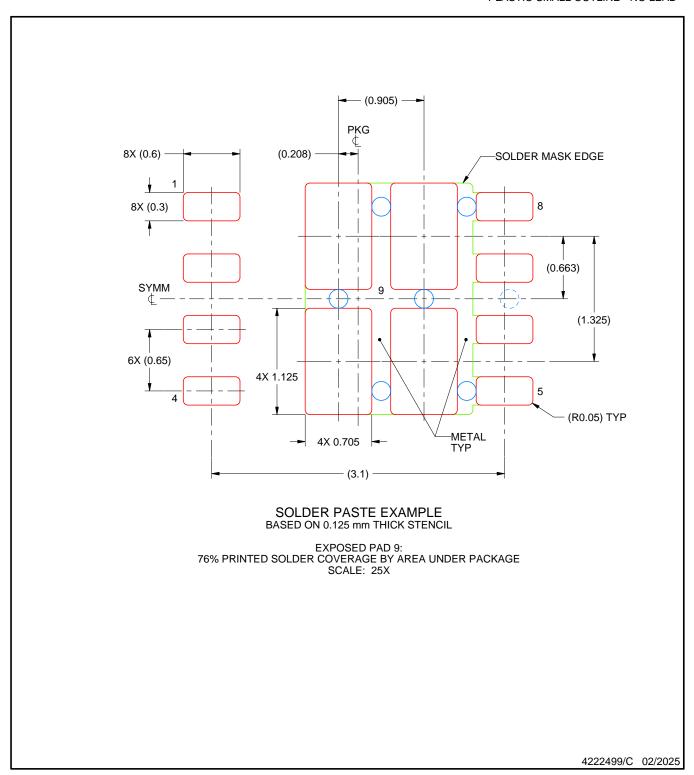


NOTES: (continued)

- 7. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 8. Vias are optional depending on application, refer to device data sheet. If some or all are implemented, recommended via locations are shown.



PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

9. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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